

# GP1A35RV

## High Sensing Accuracy OPIC Photointerrupter with Encoder Functions

### ■ Features

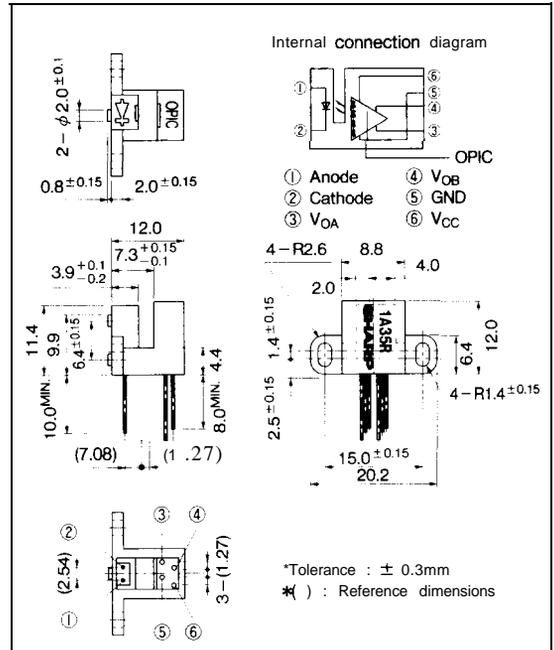
1. 2-phase (A, B) digital output
2. High sensing accuracy  
(Disk slit pitch: 0.22mm, Moire stripe application)
3. TTL compatible output
4. Compact and light

### ■ Applications

1. Copiers
2. Electronic typewriters, printers
3. Robots.
4. Numerical control machines

### ■ Outline Dimensions

(Unit : mm)



\*"OPIC" (Optical IC) is a trademark of the SHARP Corporation  
An OPIC consists of a light-detecting element and signal-processing circuit integrated onto a single chip

### ■ Absolute Maximum Ratings

(Ta = 25°C)

Parameter		Symbol	Rating	Unit
Input	Forward current	I <sub>F</sub>	65	mA
	*1 Peak forward current	I <sub>FM</sub>	1	A
	Reverse voltage	V <sub>R</sub>	6	v
	Power dissipation	P	100	mW
output	Supply voltage	V <sub>CC</sub>	7	v
	Low level output current	I <sub>OL</sub>	20	mA
	Power dissipation	P <sub>O</sub>	250	mW
Operating temperature		T <sub>opr</sub>	0 to +70	°C
Storage temperature		T <sub>stg</sub>	-40 to +80	°C
*2 Soldering temperature		T <sub>sol</sub>	260	°C

\*1 Pulse width ≤ 100 μs, Duty ratio = 0.01

\*2 For 5 seconds

Electro-optical Characteristics

(Ta = 25°C)

Parameter		Symbol	Conditions	MIN.	TYP.	MAX.	Unit			
Input	Forward voltage	V <sub>F</sub>	I <sub>F</sub> = 30mA		1.2	1.5	V			
	Reverse current	I <sub>R</sub>	V <sub>R</sub> = 3V			10	μA			
output	output voltage	Phase A	High level	V <sub>AH</sub>	V <sub>CC</sub> = 5V, I <sub>F</sub> = 30mA	2.4	4.9	v		
			Low level	V <sub>AL</sub>	I <sub>OL</sub> = 8mA, I <sub>F</sub> = 30mA, V <sub>CC</sub> = 5V	-	0.1		0.4	
		Phase B	High level	V <sub>BH</sub>	V <sub>CC</sub> = 5V, I <sub>F</sub> = 30mA	2.4	4.9			
			Low level	V <sub>BL</sub>	I <sub>OL</sub> = 8mA, I <sub>F</sub> = 30mA, V <sub>CC</sub> = 5V	-	0.1		0.4	
	Dissipation current		I <sub>CC</sub>	*3 V <sub>CC</sub> = 5V, I <sub>F</sub> = 30mA		-	-		20	mA
	Duty ratio		*4 D <sub>A</sub>	I <sub>F</sub> = 30mA		30	50		70	%
Transfer characteristics	Phase difference		*5 θ <sub>AB1</sub>	V <sub>CC</sub> = 5V	50	90	130	deg.		
	Response speed		t <sub>r</sub>	I <sub>F</sub> = 30mA, V <sub>CC</sub> = 5V	-	1.0	2.0	μs		
			t <sub>f</sub>	*6 f = 12kHz	-	1.0	2.0			

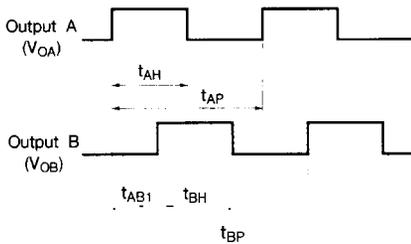
\*3 In the condition that output A and B are low level

\*4  $D_A = \frac{t_{AH}}{t_{AP}} \times 100, D_B = \frac{t_{BH}}{t_{BP}} \times 100$

\*5  $\theta_{AB1} = \frac{t_{AB1}}{t_{AP}} \times 360^\circ$

\*6 Measured under the condition shown in Measurement Conditions.

Output Waveforms



Rotational direction : Counterclockwise when seen from OPIC light detector

Fig. 1 Forward Current vs. Ambient Temperature

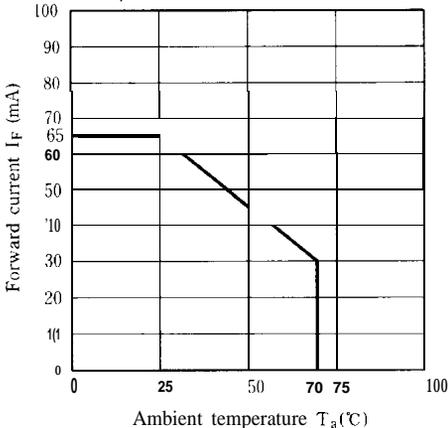
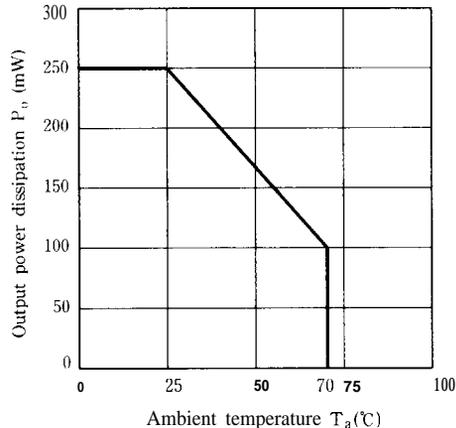
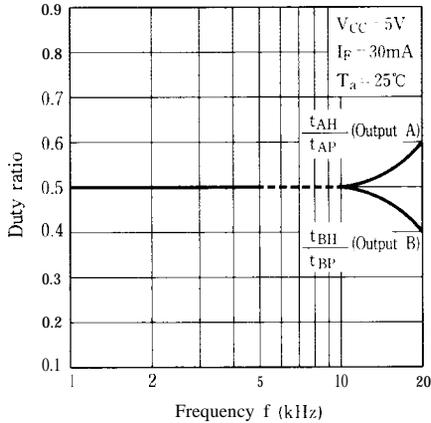


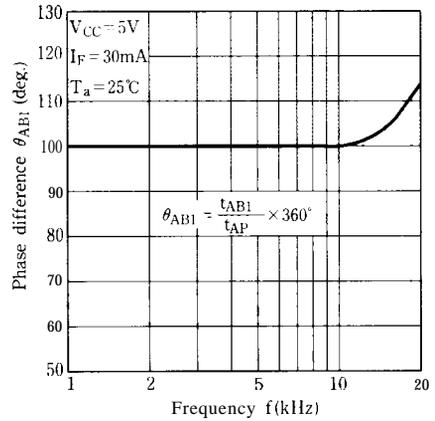
Fig. 2 Output Power Dissipation vs. Ambient Temperature



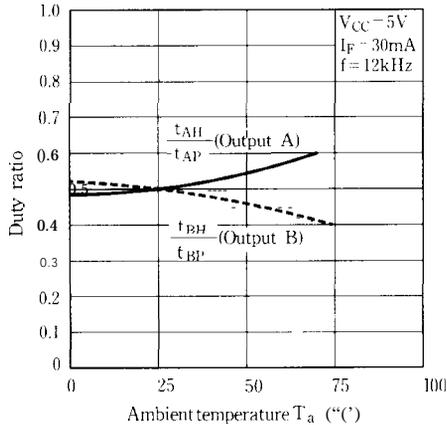
**Fig. 3 Duty Ratio vs. Frequency**



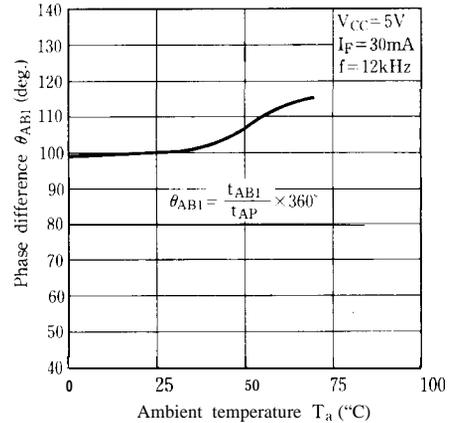
**Fig. 4 Phase Difference vs. Frequency**



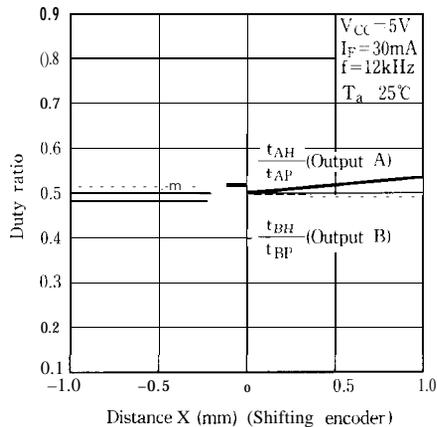
**Fig. 5 Duty Ratio vs. Ambient Temperature**



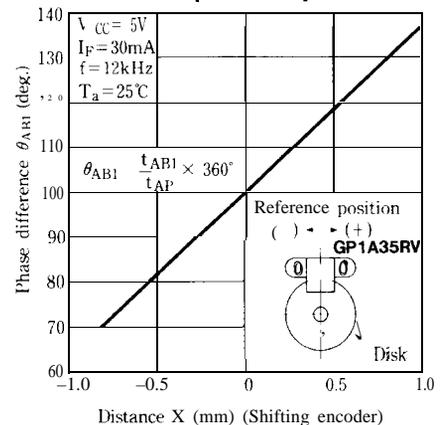
**Fig. 6 Phase Difference vs. Ambient Temperature**



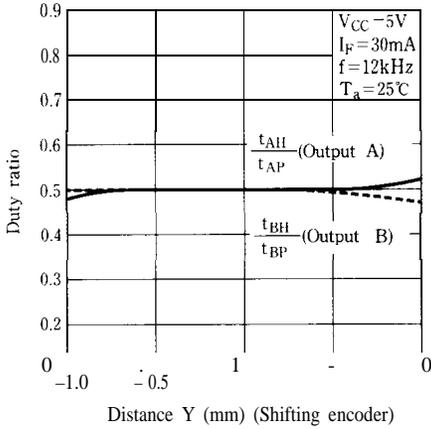
**Fig. 7 Duty Ratio vs. Distance (Xdirection)**



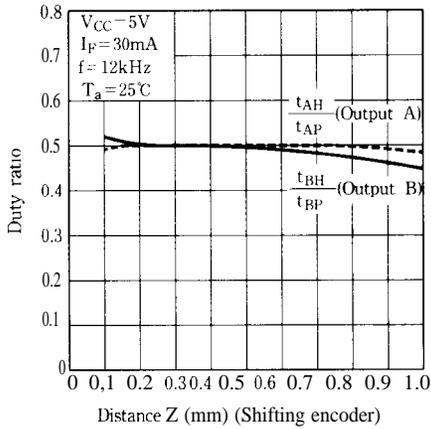
**Fig. 8 Phase Difference vs. Distance (Xdirection)**



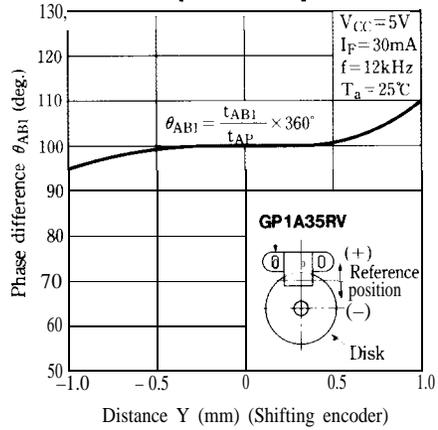
**Fig. 9 Duty Ratio vs. Distance (Ydirection)**



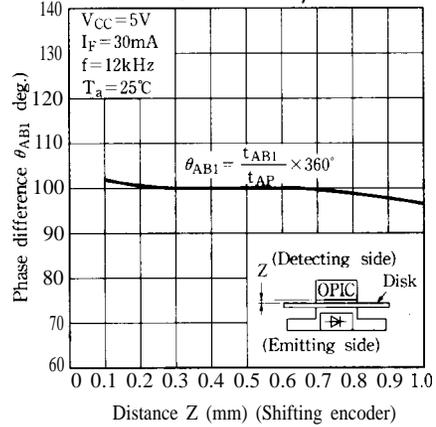
**Fig.11 Duty Ratio vs. Distance (Zdirection)**



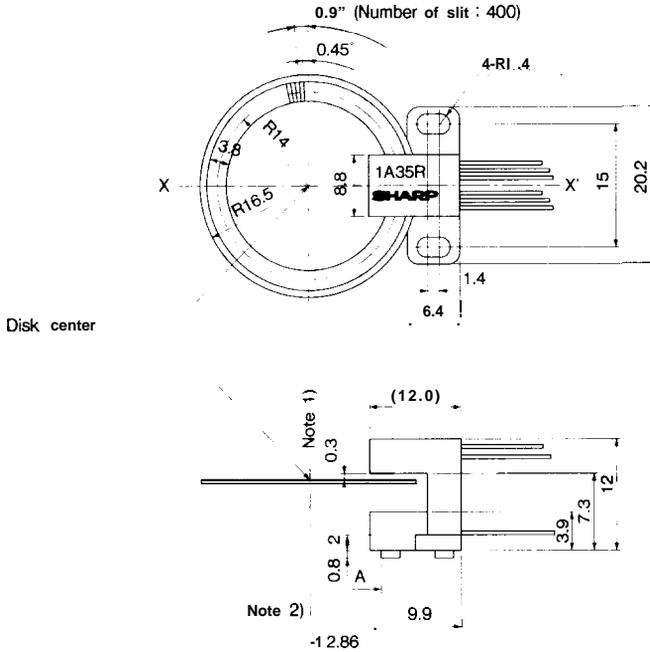
**Fig.10 Phase Difference vs. Distance (Ydirection)**



**Fig.12 Phase Difference vs. Distance (Zdirection)**



Measurement Conditions

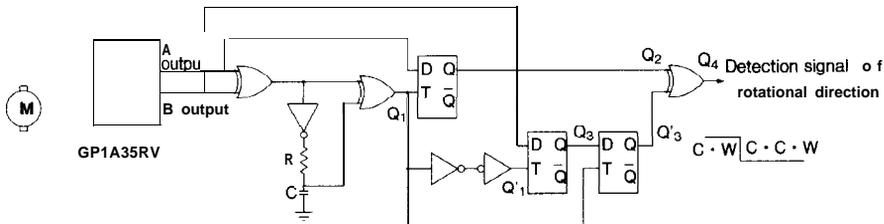


- Note 1) Distance between disk surface and case surface in the detector side is 0.3mm.  
 2) Encoder positioning pin is positioned on X-X' axis.  
 Distance between center of disk and portion A of positioning pin is 12.86 mm.  
 3) Center of disk slit is R14.0.

■ Precautions for Use

- (1) This module is designed to be operated at  $I_F=30\text{mA TYP.}$
- (2) Fixing torque: MAX.  $6\text{kg} \cdot \text{cm}$
- (3) In order to stabilize power supply line, connect a by-pass capacitor of more than  $0.01 \mu\text{F}$  between Vcc and GND near the device.
- (4) As for other general cautions, refer to the chapter "Precautions for Use" (Page 78 to 93).

■ Application Circuit (Detection of Rotational Direction)



When gate delay causes pulse noise in Q4 output, apply the CR filter to remove pulse noise.